

FORM PTO-1449/A and B (Modified) INFORMATION DISCLOSURE STATEMENT BY APPLICANT				APPLICATION NO.: 09/813,454	ATTY. DOCKET NO.: A0770/7037
				FILING DATE: March 20, 2001	
				APPLICANT: Sigurd Wagner et al.	
				GROUP ART UNIT: 2877 2826	EXAMINER: Unassigned Minhloan Tran
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U.S. PATENT DOCUMENTS

Examiner's Initials#	Cite No.	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication or of issue of Cited Document MM-DD-YYYY
		Number	Kind Code		
MLT	A1	5,185,272	B1	Makiuchi et al.	02-09-1993
MLT	A2	5,528,071	B1	Russell et al.	06-18-1996
MLT	A3	5,599,403	B1	Kariya et al.	02-04-1997
MLT	A4	5,767,712	B1	Takemae et al.	06-16-1998
MLT	A5	5,790,255	B1	Jackson et al.	08-04-1998

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		Office/Country	Number	Kind Code			
MLT	B1	EP	0 125 390	A1	SCHAUMBURG HANNO	11-21-1984	N
	B2	EP	0 559 347	A1	AMERICAN TELEPHONE AND TELEGRAPH COMPANY	09-08-1993	
	B3	JP	08 250551	A	MITSUBISHI ELECTRIC CORP.	09-27-1996	Abstract
	B4	EP	0 883 194	A1	UNIV ROMA	12-09-1998	
MLT	B5	WO	01/73850	A2	AEGIS SEMICONDUCTOR	10-04-2001	

EXAMINER Minhloan Tran	DATE CONSIDERED 1/04
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INFORMATION DISCLOSURE
STATEMENT BY APPLICANT

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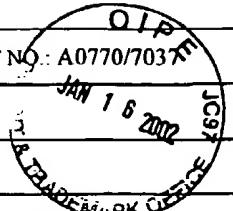
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	A2	5,162,239	B1	Winer et al.	11-10-1992
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		Office/ Country	Number	Kind Code			
MLT	B1	EP	0 139 487	A1	EXXON RES. AND ENG. CO.	05-02-1985	
	B2	JP	60 210826	A	MITSUBISHI ELECTRIC CORP.	10-23-1985	Abstract
	B3	EP	0 178 148	A2	XEROX CORPORATION	04-16-1986	
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	B5	JP	07 168040	A	NIPPON STEEL CORP.	07-04-1995	Abstract
	B6	EP	0 860 885	A2	CANON KABUSHIKI KAISHA	08-26-1998	
	B7	EP	0 899 835	A1	XEROX CORP.	03-03-1999	
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OTHER ART – NON PATENT LITERATURE DOCUMENTS

Examiner's Initials#	Cite No	Include name of the author (in CAPITAL LETTERS) title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, relevant page(s), volume-issue number(s), publisher, city and/or country where published.	Translation (Y/N)
MLT	C1	Fernandes M et al., "VIS/NIR detector based on μ -Si:H p-i-n structures", Thin Solid Films, Elsevier Science S.A., Lausanne, CH, vol. 364, no. 1-2, March 2000, pp. 204-208.	
MLT	C2	Kobayashi Y et al., "Improvement on Coupling Efficiency for Passive Alignment of Stacked Multi-Fiber Tapes to a Vertical-Cavity Surface-Emitting Laser Array", Extended Abstracts of the 1996 International Conference on Solid State Devices and Materials, Yokohama, Japan, 1996, pp. 655-657, XP 000694099	
MLT	C3	Wipiejewski T et al., "Vertical-Cavity Surface-Emitting Laser Diodes for Short Distance Optical Fiber Networks", Proceeding of the Electronic Components and Technology Conference, Washington, D.C., May 1-4, 1994, New York, IEEE, US, Vol. 44, May 1, 1994, pp 330-334, XP 000479165	

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